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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.	
10/695,327	10/27/2003	Yin-Chun Huang	JCLA9689	4865	
	7590 05/16/200 AW & TECHNOLOG		EXAMINER		
1700 NW 167T SUITE 240			VO, QU	ANG N	
BEAVERTON	, OR 97006		ART UNIT	PAPER NUMBER	
			2625		
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			MAIL DATE	DELIVERY MODE	
			05/16/2007	PAPER	

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

	Application No.	Applicant(s)	
	10/695,327	HUANG ET AL.	7
Office Action Summary	Examiner	Art Unit	
	Quang N. Vo	2625	
The MAILING DATE of this communication app Period for Reply	pears on the cover sheet with the	correspondence addres	ss
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING D. - Extensions of time may be available under the provisions of 37 CFR 1.1 after SIX (6) MONTHS from the mailing date of this communication. - If NO period for reply is specified above, the maximum statutory period of Failure to reply within the set or extended period for reply will, by statute Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tilt will apply and will expire SIX (6) MONTHS from the cause the application to become ABANDONE	N. mely filed the mailing date of this commu	·
Status	•		
1) Responsive to communication(s) filed on 27 O 2a) This action is FINAL . 2b) This 3) Since this application is in condition for alloward closed in accordance with the practice under E	action is non-final. nce except for formal matters, pro		erits is
Disposition of Claims	in parto quayro, 1000 C.D. 11, 1		
4) Claim(s) 1-13 is/are pending in the application 4a) Of the above claim(s) is/are withdray 5) Claim(s) is/are allowed. 6) Claim(s) 1-13 is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and/or Application Papers 9) The specification is objected to by the Examine	wn from consideration. or election requirement.		
10) The drawing(s) filed on is/are: a) acc Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the Ex	drawing(s) be held in abeyance. Se tion is required if the drawing(s) is ob	e 37 CFR 1.85(a). ejected to. See 37 CFR 1	
Priority under 35 U.S.C. § 119			
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of: 1. Certified copies of the priority document 2. Certified copies of the priority document 3. Copies of the certified copies of the priority application from the International Bureau * See the attached detailed Office action for a list	s have been received. s have been received in Applicate rity documents have been receive u (PCT Rule 17.2(a)).	ion No ed in this National Sta	ge
Attachment(s) Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Review (PTO-948) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date	4) Interview Summary Paper No(s)/Mail D 5) Notice of Informal F 6) Other:	ate	

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DETAILED ACTION

Claim Rejections - 35 USC § 102

The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

(b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.

Claims 1-13 are rejected under 35 U.S.C. 102(b) as being anticipated by Ulichney (USPN 4,955,065).

With regard to claim 1, Ulichney discloses a method for reducing image noise (column 3, lines 18-21), wherein the image is composed of a plurality of pixels having a scale of bits, comprising the steps: reducing a plurality of bits of the scale of each pixel in the image (column 1, lines 10-14); and recombining the scale of each pixel in the image (column 3, lines 4-13).

With regard to claim 2, Ulichney discloses wherein after the step of recombining the scale of each pixel in the image, further comprising a step: filling out missing codes of each pixel of the image (column 3, lines 4-13).

With regard to claim 3, Ulichney discloses wherein the step of reducing a plurality of bits of the scale of each pixel in the image can reduce the scale of each pixel in the image (column 6, lines 11-21).

With regard to claim 4, Ulichney discloses wherein the step of recombining the scale of each pixel in the image comprises a halftone pattern method (column 3, lines 65-67).

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With regard to claim 5, Ulichney discloses wherein a pattern composed by the halftone pattern method is a matrix pattern (column 12, line 9 – column 13, line 21).

With regard to claim 6, Ulichney discloses wherein the row and column numbers of the matrix pattern are dependent on the number of bits reduced in the step of reducing a plurality of bits of the scale of each pixel in the image (column 10, lines 59-66).

With regard to claim 7, Ulichney discloses wherein the step of filling out missing codes of the pixels of the image comprises a bit enhance method (column 3, lines 8-13).

With regard to claim 8, Ulichney discloses a method for reducing image noise (column 3, lines 18-21), wherein the image is composed of a plurality of pixels having a scale of bits, comprising the steps: reducing a plurality of bits of the scale of each pixel in the image (column 1, lines 10-14); recombining the scale of each pixel in the image; and filling out missing codes of each pixel of the (column 3, lines 4-13).

With regard to claim 9, Ulichney discloses wherein the step of reducing a plurality of bits of the scale of each pixel in the image can reduce the scale of each pixel in the image (column 6, lines 11-21).

With regard to claim 10, Ulichney discloses wherein the step of recombining the scale of each pixel in the image comprises a halftone pattern method (column 3, lines 65-67).

With regard to claim 11, Ulichney discloses wherein a pattern composed by the halftone pattern method is a matrix pattern (column 12, line 9 – column 13, line 21).

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With regard to claim 12, Ulichney discloses wherein the row and column numbers of the matrix pattern are dependent on the number of bits reduced in the step of reducing a plurality of bits of the scale of each pixel in the image (column 10, lines 59-66).

With regard to claim 13, Ulichney discloses wherein the step of filling out missing codes of the pixels of the image comprises a bit enhance method (column 3, lines 8-13).

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Quang N. Vo whose telephone number is 5712701121. The examiner can normally be reached on 7:30AM-5:00PM Monday-Friday.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Twyler M. Lamb can be reached on 5712727406. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free). If you would like assistance from a USPTO Customer Service Representative or access to the automated information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

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Quanglo Quang N. Vo Patent Examiner

5/7/07

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